

## 4-bit binary counter

## 74ALS161B/74ALS163B

74ALS161B 4-bit binary counter, asynchronous reset

74ALS163B 4-bit binary counter, synchronous reset

## FEATURES

- Synchronous counting and loading
- Two count enable inputs for n-bit cascading
- Positive edge-triggered clock
- Asynchronous reset (74ALS161B)
- Synchronous reset (74ALS163B)
- High speed synchronous expansion
- Typical count rate of 140MHz

TYPE	TYPICAL $f_{MAX}$	TYPICAL SUPPLY CURRENT (TOTAL)
74ALS161B	140MHz	10mA
74ALS163B	140MHz	10mA

## ORDERING INFORMATION

DESCRIPTION	ORDER CODE	DRAWING NUMBER
	COMMERCIAL RANGE $V_{CC} = 5V \pm 10\%$ , $T_{amb} = 0^{\circ}C$ to $+70^{\circ}C$	
16-pin plastic DIP	74ALS161BN, 74ALS163BN	SOT38-4
16-pin plastic SO	74ALS161BD, 74ALS163BD	SOT109-1
16-pin plastic SSOP Type II	74ALS161BDB, 74ALS163BDB	SOT338-1

## DESCRIPTION

Synchronous presettable 4-bit binary counters (74ALS161B, 74ALS163B) feature an internal carry look-ahead and can be used for high speed counting. Synchronous operation is provided by having all flip-flops clocked simultaneously on the positive-going edge of the clock. The clock input is buffered.

The outputs of the counters may be preset to High or Low level. A Low level at the parallel enable (PE) input disables the counting action and causes the data at the D0 – D3 inputs to be loaded into the counter on the positive-going edge of the clock (provided that the setup and hold requirements for PE are met). Preset takes place regardless of the levels at count enable (CEP, CET) inputs.

A Low level at the master reset ( $\overline{MR}$ ) input sets all the four outputs of the flip-flops (Q0 – Q3) in 74ALS161B to Low levels, regardless of the levels at CP, PE, CET and CEP inputs (thus providing an asynchronous clear function).

For the 74ALS163B the clear function is synchronous. A Low level at the synchronous reset ( $\overline{SR}$ ) input sets all four outputs of the flip-flops (Q0 – Q3) to Low levels after the next positive-going transition on the clock (CP) input ( provided that the setup and hold time requirements for SR are met). This action occurs regardless of the levels at CP, PE, CET and CEP inputs. The synchronous reset feature enables the designer to modify the maximum count with only one external NAND gate (see Figure 1).

The carry look-ahead simplifies serial cascading of the counters. Both count enable (CEP and CET) inputs must be High to count. The CET input is fed forward to enable the TC output. The TC output thus enabled will produce a High output pulse of a duration approximately equal to the High level output of Q0. This pulse can be used to enable the next cascaded stage (see Figure 2).

The TC output is subjected to decoding spikes due to internal race conditions. Therefore, it is not recommended for use as clock or asynchronous reset for flip-flops, registers, or counters.

## INPUT AND OUTPUT LOADING AND FAN-OUT TABLE

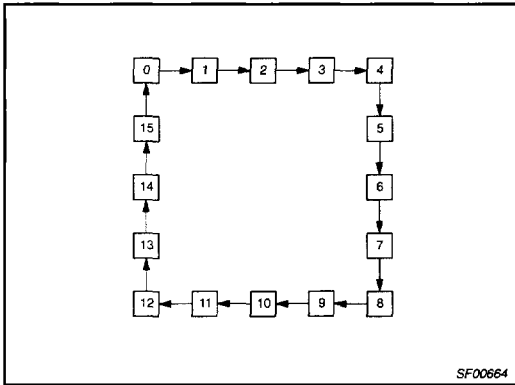
PINS	DESCRIPTION	74ALS (U.L.) HIGH/LOW	LOAD VALUE HIGH/LOW
D0 – D3	Data inputs	1.0/1.0	20 $\mu$ A/0.1mA
CEP	Count enable parallel input (active-Low)	1.0/1.0	20 $\mu$ A/0.1mA
CET	Count enable trickle input (active-Low)	1.0/1.0	20 $\mu$ A/0.1mA
CP	Clock input (active rising edge)	1.0/1.0	20 $\mu$ A/0.1mA
PE	Parallel enable input (active-Low)	1.0/1.0	20 $\mu$ A/0.1mA
$\overline{MR}$	Asynchronous master reset input (active-Low) for 74ALS161B	1.0/1.0	20 $\mu$ A/0.1mA
$\overline{SR}$	Asynchronous reset input (active-Low) for 74ALS163B	1.0/1.0	20 $\mu$ A/0.1mA
Q0 – Q3	Flip-flop outputs	20/80	0.4mA/8mA
TC	Terminal count output (active-Low)	20/80	0.4mA/8mA

NOTE: One (1.0) ALS unit load is defined as: 20 $\mu$ A in the High state and 0.1mA in the Low state.

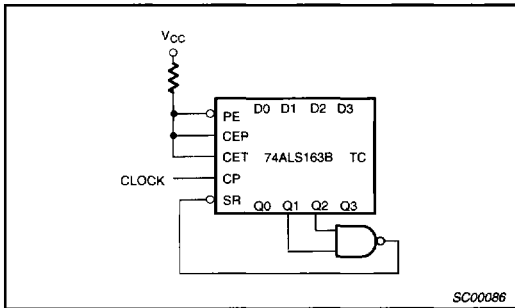
# 4-bit binary counter

# 74ALS161B/74ALS163B

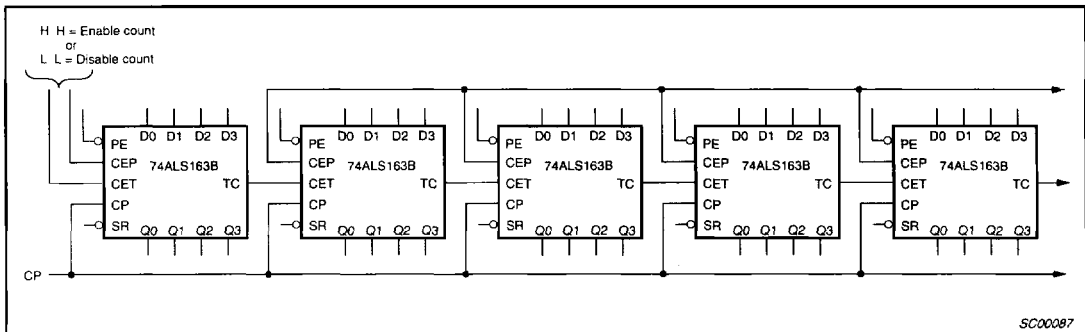
## STATE DIAGRAM



## APPLICATIONS



**Figure 1. Maximum Count Modifying Scheme**  
Terminal Count = 6

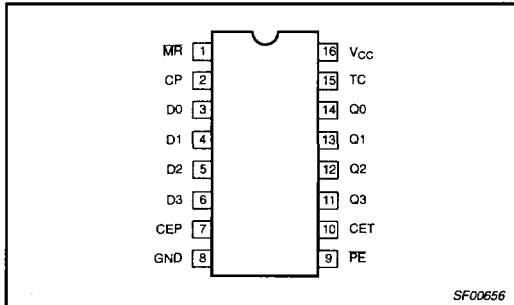


**Figure 2. Synchronous Multistage Counting Scheme**

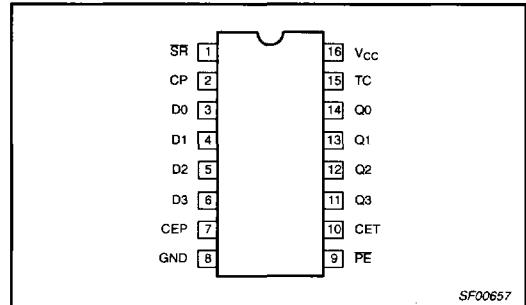
# 4-bit binary counter

# 74ALS161B/74ALS163B

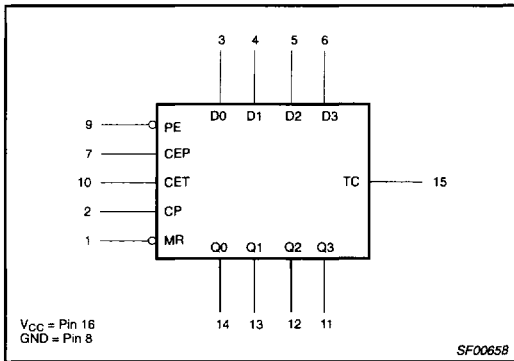
**PIN CONFIGURATION – 74ALS161B**



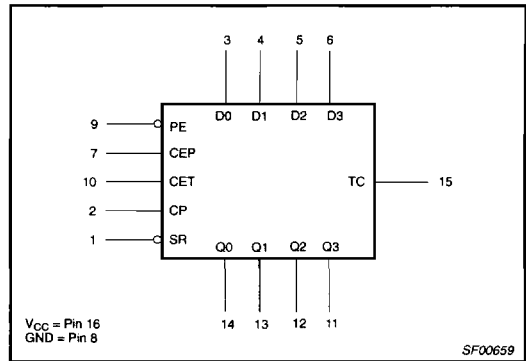
**PIN CONFIGURATION – 74ALS163B**



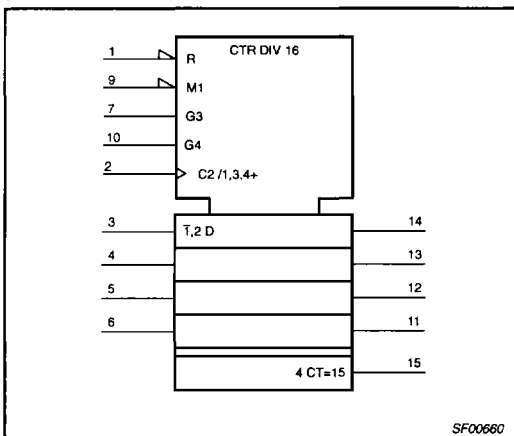
**LOGIC SYMBOL – 74ALS161B**



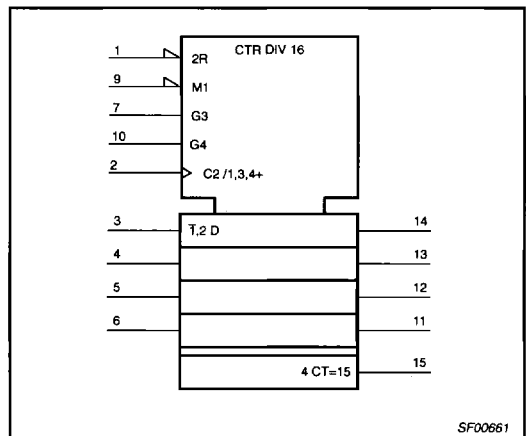
**LOGIC SYMBOL – 74ALS163B**



**IEC/IEEE SYMBOL – 74ALS161B**



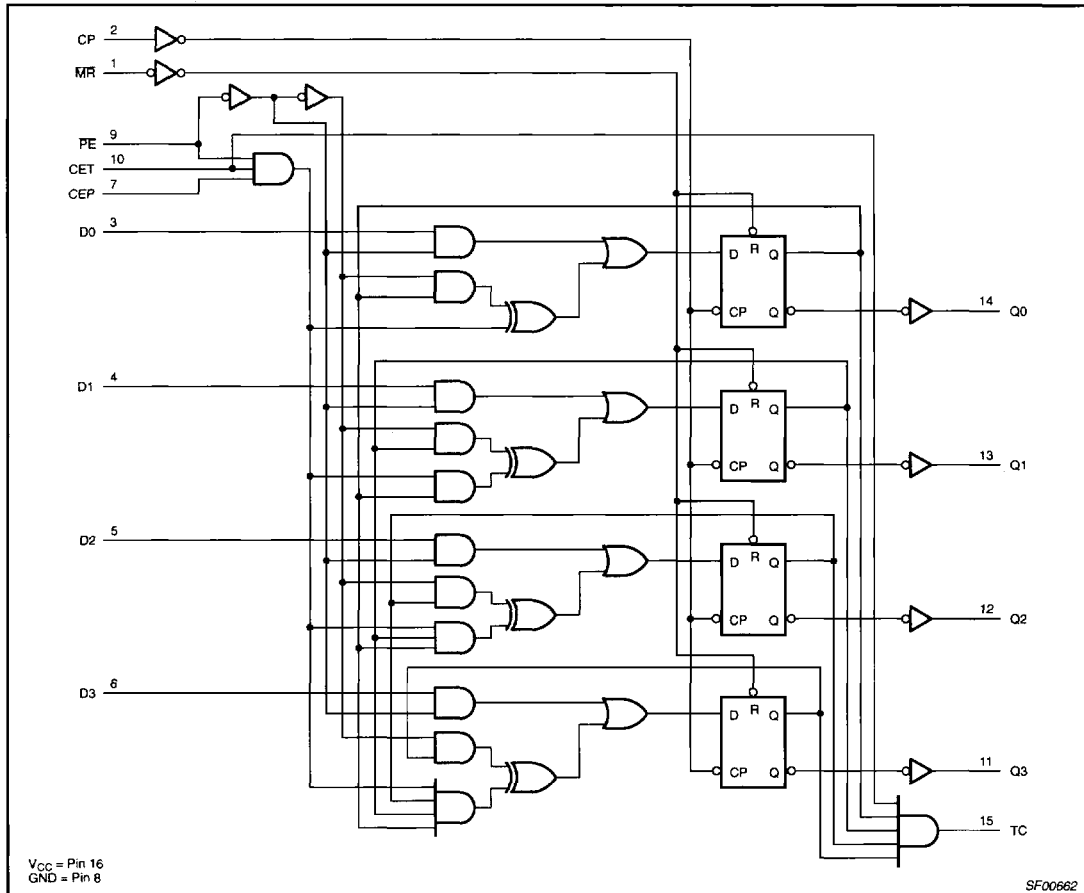
**IEC/IEEE SYMBOL – 74ALS163B**



4-bit binary counter

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LOGIC DIAGRAM – 74ALS161B



MODE SELECTION FUNCTION TABLE – 74ALS161B

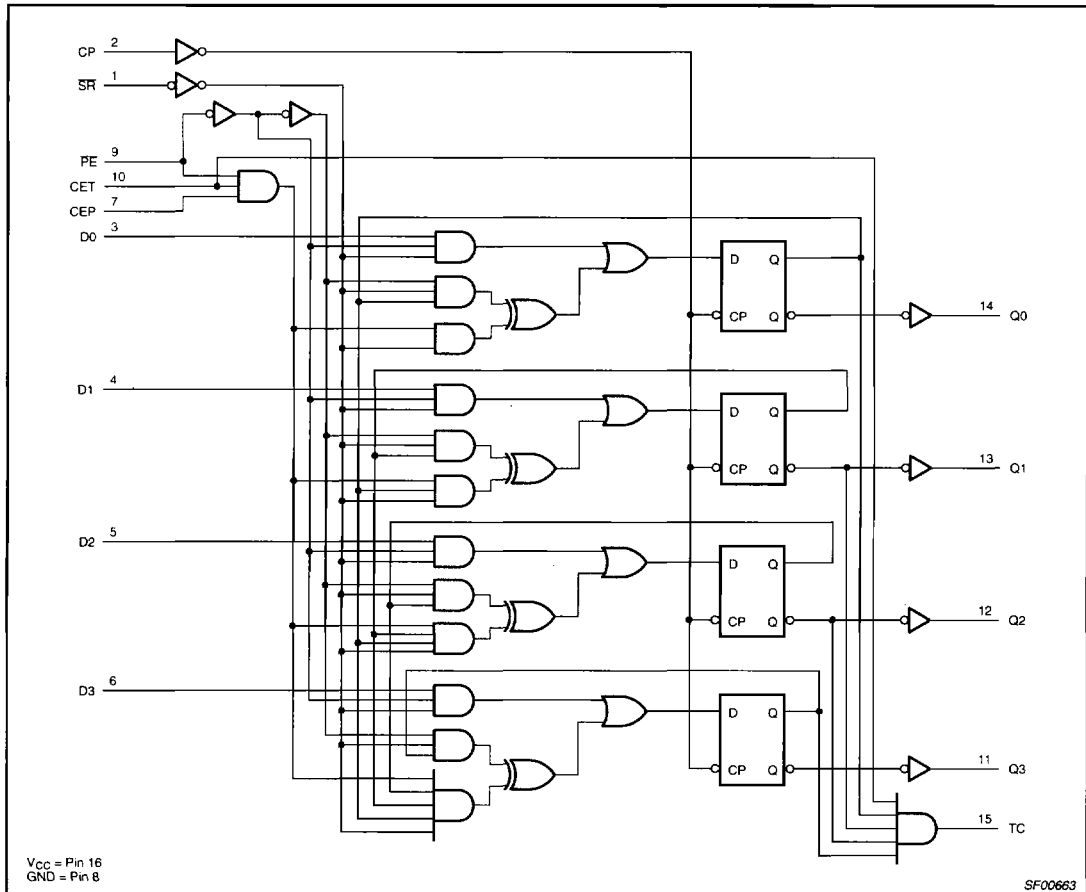
INPUTS						OUTPUTS		OPERATING MODE
MR	CP	CEP	CET	PE	Dn	Qn	TC	
L	X	X	X	X	X	L	L	Reset (clear)
H	↑	X	X	l	l	L	L	Parallel load
H	↑	X	X	l	h	H	(a)	
H	↑	h	h	h	X	count	(a)	Count
h	X	l	X	h	X	qn	(a)	Hold (do nothing)
h	X	X	l	h	X	qn	L	

H = High-voltage level  
 h = High state must be present one setup time before the Low-to-High clock transition  
 L = Low-voltage level  
 l = Low state must be present one setup time before the Low-to-High clock transition  
 qn = Lower case letters indicate the state of the referenced output prior to the Low-to-High clock transition  
 X = Don't care  
 (a) = The output is High when CET is High and the counter is at terminal count (HHHH)  
 ↑ = Low-to-High clock transition

4-bit binary counter

74ALS161B/74ALS163B

LOGIC DIAGRAM – 74ALS163B



MODE SELECTION FUNCTION TABLE – 74ALS163B

INPUTS						OUTPUTS		OPERATING MODE
SR	CP	CEP	CET	PE	Dn	Qn	TC	
l	↑	X	X	X	X	L	L	Reset (clear)
h	↑	X	X	l	l	L	L	Parallel load
h	↑	X	X	l	h	H	(a)	Count
h	↑	h	h	h	X	count	(a)	Count
h	X	l	X	h	X	qn	(a)	Hold (do nothing)
h	X	X	l	h	X	qn	L	Hold (do nothing)

H = High-voltage level  
 h = High state must be present one setup time before the Low-to-High clock transition  
 L = Low-voltage level  
 l = Low state must be present one setup time before the Low-to-High clock transition  
 qn = Lower case letters indicate the state of the referenced output prior to the Low-to-High clock transition  
 X = Don't care  
 (a) = The output is High when CET is High and the counter is at terminal count (HHHH)  
 ↑ = Low-to-High clock transition

## 4-bit binary counter

## 74ALS161B/74ALS163B

**ABSOLUTE MAXIMUM RATINGS**

(Operation beyond the limit set forth in this table may impair the useful life of the device.  
Unless otherwise noted these limits are over the operating free air temperature range.)

SYMBOL	PARAMETER	RATING	UNIT
$V_{CC}$	Supply voltage	-0.5 to +7.0	V
$V_{IN}$	Input voltage	-0.5 to +7.0	V
$I_{IN}$	Input current	-30 to +5	mA
$V_{OUT}$	Voltage applied to output in High output state	-0.5 to $V_{CC}$	V
$I_{OUT}$	Current applied to output in Low output state	16	mA
$T_{amb}$	Operating free-air temperature range	0 to +70	°C
$T_{stg}$	Storage temperature range	-65 to +150	°C

**RECOMMENDED OPERATING CONDITIONS**

SYMBOL	PARAMETER	LIMITS			UNIT
		MIN	NOM	MAX	
$V_{CC}$	Supply voltage	4.5	5.0	5.5	V
$V_{IH}$	High-level input voltage	2.0			V
$V_{IL}$	Low-level input voltage			0.8	V
$I_{IK}$	Input clamp current			-18	mA
$I_{OH}$	High-level output current			-0.4	mA
$I_{OL}$	Low-level output current			8	mA
$T_{amb}$	Operating free-air temperature range	0		+70	°C

**DC ELECTRICAL CHARACTERISTICS**

(Over recommended operating free-air temperature range unless otherwise noted.)

SYMBOL	PARAMETER	TEST CONDITIONS <sup>1</sup>	LIMITS			UNIT
			MIN	TYP <sup>2</sup>	MAX	
$V_{OH}$	High-level output voltage	$V_{CC} = \pm 10\%$ , $V_{IL} = \text{MAX}$ , $V_{IH} = \text{MIN}$ , $I_{OH} = -0.4\text{mA}$	$V_{CC} - 2$			V
$V_{OL}$	Low-level output voltage	$V_{CC} = \text{MIN}$ , $V_{IL} = \text{MAX}$ , $V_{IH} = \text{MIN}$ , $I_{OL} = 4\text{mA}$		0.25	0.40	V
				0.35	0.50	V
$V_{IK}$	Input clamp voltage	$V_{CC} = \text{MIN}$ , $I_I = I_{IK}$		-0.73	-1.5	V
$I_I$	Input current at minimum input voltage	$V_{CC} = \text{MAX}$ , $V_I = 7.0\text{V}$			0.1	mA
$I_{IH}$	High-level input current	$V_{CC} = \text{MAX}$ , $V_I = 2.7\text{V}$			20	μA
$I_{IL}$	Low-level input current	$V_{CC} = \text{MAX}$ , $V_I = 0.4\text{V}$			-0.1	mA
$I_O$	Output current <sup>3</sup>	$V_{CC} = \text{MAX}$ , $V_O = 2.25\text{V}$	-30		-112	mA
$I_{CC}$	Supply current (total)	$V_{CC} = \text{MAX}$		10	21	mA

**NOTES:**

- For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type.
- All typical values are at  $V_{CC} = 5\text{V}$ ,  $T_{amb} = 25^\circ\text{C}$ .
- The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current,  $I_{OS}$ .

## 4-bit binary counter

## 74ALS161B/74ALS163B

## AC ELECTRICAL CHARACTERISTICS

SYMBOL	PARAMETER		TEST CONDITION	LIMITS		UNIT
				$T_{amb} = 0^{\circ}\text{C to } +70^{\circ}\text{C}$ $V_{CC} = +5.0\text{V} \pm 10\%$ $C_L = 50\text{pF}, R_L = 500\Omega$		
				MIN	MAX	
$f_{MAX}$	Maximum clock frequency		Waveform 1	100		MHz
$t_{PLH}$ $t_{PHL}$	Propagation delay CP to Qn		Waveform 1	4.0 6.0	13.0 16.0	ns
$t_{PLH}$ $t_{PHL}$	Propagation delay CP to TC		Waveform 1	6.0 8.0	16.0 16.0	ns
$t_{PLH}$ $t_{PHL}$	Propagation delay CET to TC		Waveform 2	3.0 3.0	10.0 10.0	ns
$t_{PHL}$	Propagation delay MR to Qn	74ALS161B	Waveform 3	8.0	15.0	ns
$t_{PHL}$	Propagation delay MR to TC	74ALS163B	Waveform 3	11.0	19.0	ns

## AC ELECTRICAL CHARACTERISTICS

SYMBOL	PARAMETER		TEST CONDITION	LIMITS		UNIT
				$T_{amb} = 0^{\circ}\text{C to } +70^{\circ}\text{C}$ $V_{CC} = +5.0\text{V} \pm 10\%$ $C_L = 50\text{pF}, R_L = 500\Omega$		
				MIN	MAX	
$t_{su(H)}$ $t_{su(L)}$	Setup time, High or Low Dn to CP		Waveform 6	8.0 8.0		ns
$t_h(H)$ $t_h(L)$	Hold time, High or Low Dn to CP		Waveform 6	0.0 0.0		ns
$t_{su(H)}$ $t_{su(L)}$	Setup time, High or Low PE or SR to CP		Waveform 5 or 6	10.0 10.0		ns
$t_h(H)$ $t_h(L)$	Hold time, High or Low PE or SR to CP		Waveform 6	0.0 0.0		ns
$t_{su(H)}$ $t_{su(L)}$	Setup time, High or Low CET or CEP to CP		Waveform 4	10.0 10.0		ns
$t_h(H)$ $t_h(L)$	Hold time, High or Low CET or CEP to CP		Waveform 4	0.0 0.0		ns
$t_w(H)$ $t_w(L)$	CP Pulse width (load), High or Low		Waveform 1	5.0 5.0		ns
$t_w(H)$ $t_w(L)$	CP Pulse width (count), High or Low		Waveform 1	5.0 5.0		ns
$t_w(L)$	MR or SR Pulse width, Low		Waveform 3	5.0		ns
$t_{REC}$	Recovery time, CR or SR to CP		Waveform 3	10.0		ns

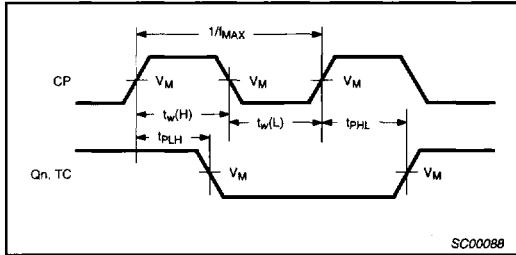
# 4-bit binary counter

# 74ALS161B/74ALS163B

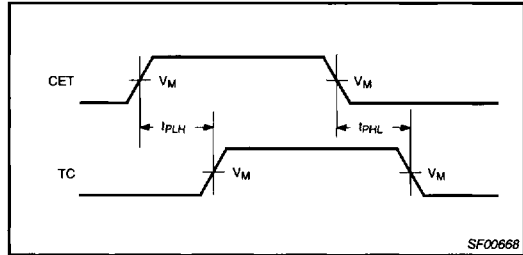
## AC WAVEFORMS

For all waveforms,  $V_M = 1.3V$ .

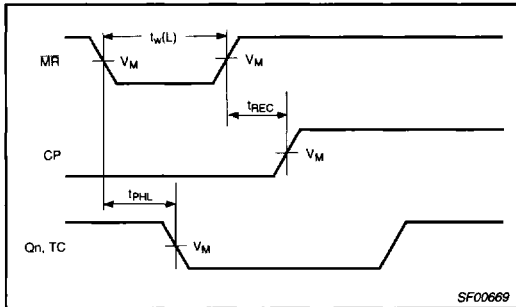
The shaded areas indicate when the input is permitted to change for predictable output performance.



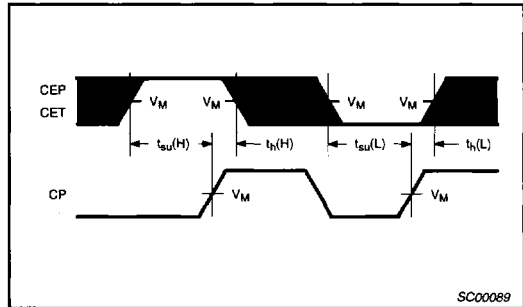
**Waveform 1. Propagation Delay for Clock Input to Output, Clock Pulse Width, and Maximum Clock Frequency**



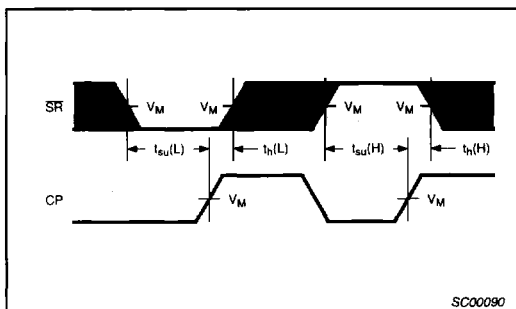
**Waveform 2. Propagation Delay for CET to TC Output**



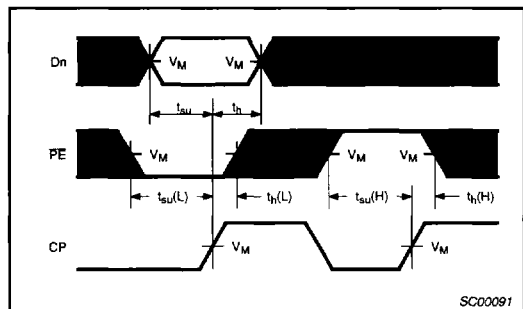
**Waveform 3. Master Reset Pulse Width, Master Reset to Output Delay, and Master Reset to Clock Recovery Time**



**Waveform 4. CEP and CET Setup and Hold Times**



**Waveform 5. Synchronous Reset Setup and Hold Times**



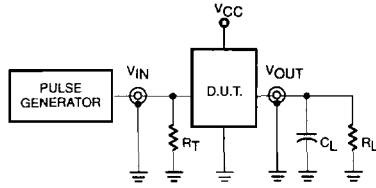
**Waveform 6. Data and Parallel Enable Setup and Hold Times**



# 4-bit binary counter

# 74ALS161B/74ALS163B

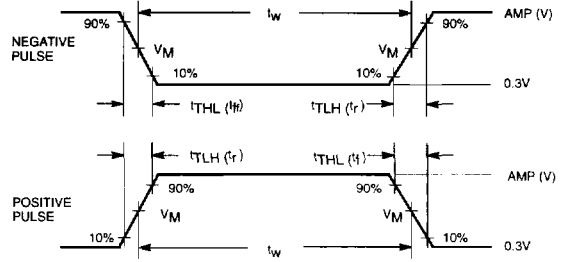
## TEST CIRCUIT AND WAVEFORMS



Test Circuit for Totem-pole Outputs

**DEFINITIONS:**

- $R_L$  = Load resistor; see AC electrical characteristics for value.
- $C_L$  = Load capacitance includes jig and probe capacitance; see AC electrical characteristics for value.
- $R_T$  = Termination resistance should be equal to  $Z_{OUT}$  of pulse generators.



Input Pulse Definition

Family	INPUT PULSE REQUIREMENTS					
	Amplitude	$V_M$	Rep. Rate	$t_w$	$t_{TLH}$	$t_{THL}$
74ALS	3.5V	1.3V	1MHz	500ns	2.0ns	2.0ns

SC00005